


<b>Search Notes</b>  	<b>Application/Control No.</b>  10772805	<b>Applicant(s)/Patent Under Reexamination</b>  KEENAN, MICHAEL R.
	<b>Examiner</b>  Abdelnour, Farras	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
keenan-michael\$.in.	6/14/2007	FA
(concentration ADJ3 matrix) AND (spectral ADJ3 shape) AND wavelet	6/18/2007	FA
(principal ADJ3 component\$) AND wavelet\$ AND concentration AND image	6/18/2007	FA
(scor\$ ADJ3 matrix) AND (loading ADJ3 matrix) AND wavelet	6/18/2007	FA
((principal\$ ADJ3 component\$) OR SVD) AND matrix AND image AND wavelet	6/18/2007	FA
(data ADJ3 factor) AND (concentration ADJ3 matrix) AND (spectral ADJ3 shape) AND wavelet	6/19/2007	FA
Updated search, US-PGPUB, USPAT, EPO, JPO	11/26/2007	FA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner